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**COMPLETE IF KNOWN** Application Number 09/848,520 Confirmation Number 7535 Filing Date May 3, 2001 Technology Center 2100 First Named Inventor Eric C. Berg et al. Group Art Unit 2123 Examiner Name Attorney Docket Number 8070ML\$&

## **U. S. PATENT DOCUMENTS**

EXAMINER INITIALS*	Cite No. <sup>1</sup>	DOCUMENT NUMBER  Number - Kind Code <sup>2</sup> (If known)	Publication Date MM-OD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
712		US-5,210,704	05/11/1993	Husseiny	
m		US-5,455,777	10/03/1995	Fujiyama et al.	
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## **FOREIGN PATENT DOCUMENTS**

EXAMINER INITIALS*	Cite No.1	FOREIGN PATENT DOCUMENT  Country Code <sup>3</sup> Number <sup>4</sup> Kind Code <sup>5</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T⁵
F3		EP 0878 761 A1	11/18/1998	NEC Corporation		
93		WO 98/24042 A1	06/04/1998	Sundstrand Corporation		
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## OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS

EXAMINER INITIALS'	Cite No. <sup>1</sup>	include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published		
Per		NICOL, DAVID M., "A Graphical Model-Based Reliability Estimation Tool and Failure Mode & Effects Simulator", 1995 PROCEEDINGS Annual RELIABILITY and MAINTAINABILITY Symposium, Jan. 16, 1995, New York, IEEE, pp. 74-81.		
N	PALUMBO, DANIEL L., "Using Failure Modes and Effects Simulation as a Means of Reliability Analysis", PROCEEDINGS OF THE DIGITAL AVIONICS SYSTEMS CONFERENCE, Seattle, Oct. 5, 1992, New York, IEEE, Vol. Conf. 11, pp. 102-107.			
EXAMINE	1	DATE CONSIDERED 11/2/04	<del></del>	

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